The listing of claims will replace all prior versions, and listings, of claims in the application:

Listing of Claims:

- 1. (Currently Amended) A semiconductor device comprising:
- a support base interposed between a pair of first adhesives;
- a thin film integrated circuit, an antenna, and a separating layer over the pair of first adhesives;
 - a wiring electrically connecting the thin film integrated circuit and the antenna;
 - a second adhesive over the wiring; and
 - a cover material over the second adhesive.
 - wherein the wiring passes through the separating layer, and
- wherein the pair of first adhesives has a higher adhesion than the separating layer.
 - 2. (Currently Amended) A semiconductor device comprising:
 - a support base interposed between a pair of first adhesives;
- a thin film integrated circuit, a separating layer, and an antenna sequentially laminated over the pair of first adhesives;
 - a wiring electrically connecting the thin film integrated circuit and the antenna;
 - a second adhesive over the wiring; and
 - a cover material over the second adhesive.
 - wherein the wiring passes through the separating layer, and
- wherein the pair of first adhesives has a higher adhesion than the separating <u>layer</u>.
 - 3. (Currently Amended) A semiconductor device comprising:

a support base interposed between a pair of first adhesives;

a thin film integrated circuit, an antenna, and a separating layer over the pair of first adhesives, wherein the thin film integrated circuit comprises a plurality of semiconductor elements:

a wiring electrically connecting the plurality of semiconductor elements;

a second adhesive over the wiring; and

a cover material over the second adhesive.

wherein the wiring passes through the separating layer, and

wherein the pair of first adhesives has a higher adhesion than the separating layer.

- 4. (Original) A semiconductor device according to any one of claims 1 to 3, wherein the antenna is formed by one of a printing method and a droplet discharging method.
- 5. (Previously Presented) A semiconductor device according to claim 3, wherein the plurality of semiconductor elements comprise thin film transistors, wherein each of the thin film transistors comprises a semiconductor film and a gate electrode with a gate insulating film interposed therebetween.
- 6. (Original) A semiconductor device according to claim 5, wherein the antenna and the gate electrode are formed by patterning a same conductive film.
- 7. (Previously Presented) A semiconductor device according to any one of claims 1 to 3, wherein the thin film integrated circuit and the antenna are formed over a substrate and then peeled off by removing the substrate, and stuck to the support base using one of the pair of first adhesives.

- 8. (Currently Amended) A semiconductor device comprising:
- a support base interposed between a pair of first adhesives;
- a thin film integrated circuit, an antenna, and a separating layer over the pair of first adhesives:
 - a second adhesive over the antenna; and
 - a cover material over the second adhesive.

wherein the antenna comprises a plurality of wirings connected in series, and wherein at least one of the plurality of wirings passes through the separating layer, and

wherein the pair of first adhesives has a higher adhesion than the separating layer.

- 9. (Previously Presented) A semiconductor device according to claim 8, wherein the thin film integrated circuit and the antenna are formed over a substrate and then peeled off the substrate by removing the substrate, and stuck to the support base using one of the pair of first adhesives.
 - 10. (Currently Amended) A semiconductor device comprising:
 - a support base interposed between a pair of first adhesives;
- a thin film integrated circuit, an antenna, and a separating layer sequentially laminated over the pair of first adhesives;
 - a second adhesive over the antenna; and
 - a cover material over the second adhesive,
 - wherein the antenna comprises a plurality of wirings connected in series, [[and]]
- wherein at least one of the plurality of wirings passes through the separating layer, and

wherein the pair of first adhesives has a higher adhesion than the separating layer.

- (Previously Presented) A semiconductor device according to claim 10, 11. wherein the thin film integrated circuit and the antenna are formed over a substrate and then peeled off the substrate by removing the substrate, and stuck to the support base using one of the pair of first adhesives.
- 12. (Original) A semiconductor device according to any one of claims 1 to 3, 8 and 10, wherein the separating layer comprises a metal oxide film containing at least one selected from the group consisting of TiN, WN, Mo and W.
- 13. (Original) A semiconductor device according to claim 12, wherein the metal oxide film is in a crystalline state.
- 14. (Original) A semiconductor device according to any one of claims 1 to 3, 8 and 10, wherein the support base comprises at least one of a plastic and a paper.
- 15. (Original) A semiconductor device according to any one of claims 1 to 3, 8 and 10, wherein the semiconductor device is stuck to an object selected from the group consisting of a container, an envelope, a check and a passport.